Application/Control No. Applicant(s)/Patent Under Reexamination 10/643,840 **GUTHRIE, DAVID** Notice of References Cited Examiner Art Unit Page 1 of 1 Kelvin Lin 2142 **U.S. PATENT DOCUMENTS** Document Number Date Name Classification Country Code-Number-Kind Code MM-YYYY * US-6,771,290 08-2004 Hoyle, Martin David 715/745 Α * 07-2000 Wang et al. 709/229 US-6,085,249 В US-С US-Đ US-Ε US-F US-G US-Н US-US-US-Κ US-US-Μ FOREIGN PATENT DOCUMENTS Document Number Date Name Country Classification Country Code-Number-Kind Code MM-YYYY Ν 0 Ρ Q R s Т **NON-PATENT DOCUMENTS** Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) U W

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